ALPHA & OMEGA SEMICONDUCTOR, LTD

AO8822

Common-Drain Dual N-Channel Enhancement Mode Field Effect Transistor

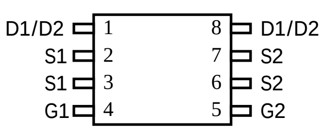
General Description

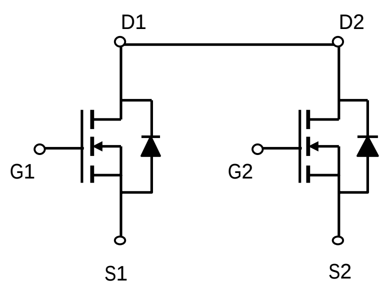
The AO8822 uses advanced trench technology to provide excellent $R_{DS(ON)}$, low gate charge and operation with gate voltages as low as 1.8V while retaining a 12V $V_{GS(MAX)}$ rating. This device is suitable for use as a uni-directional or bi-directional load switch, facilitated by its common-drain configuration. *Standard Product AO8822 is Pb-free (meets ROHS & Sony 259 specifications). AO8822L is a Green Product ordering option. AO8822 and AO8822L are electrically identical.*

Features

V_{DS} (V) = 20V
I_D = 7 A (V_{GS} = 10V)
$R_{DS(ON)}$ < 21mΩ (V_{GS} = 10V)
$R_{DS(ON)}$ < 24mΩ (V_{GS} = 4.5V)
$R_{DS(ON)}$ < 32mΩ (V_{GS} = 2.5V)
$R_{DS(ON)}$ < 50mΩ (V_{GS} = 1.8V)

TSSOP-8
Top View





Absolute Maximum Ratings T_A=25°C unless otherwise noted

Parameter		Symbol	Maximum	Units
Drain-Source Voltage		V_{DS}	20	V
Gate-Source Voltage		V_{GS}	±12	V
Continuous Drain Current [A]	T_A=25°C	I_D	7	A
	T_A=70°C		5.7	
Pulsed Drain Current [B]		I_{DM}	30	
Power Dissipation [A]	T_A=25°C	P_D	1.5	W
	T_A=70°C		0.96	
Junction and Storage Temperature Range		T_J, T_{STG}	-55 to 150	°C

Thermal Characteristics

Parameter		Symbol	Typ	Max	Units
Maximum Junction-to-Ambient [A]	t ≤ 10s	$R_{\theta JA}$	63	83	°C/W
Maximum Junction-to-Ambient [A]	Steady-State		101	130	°C/W
Maximum Junction-to-Lead [C]	Steady-State	$R_{\theta JL}$	64	83	°C/W

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Electrical Characteristics (T_J=25°C unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
STATIC PARAMETERS						
BV_{DSS}	Drain-Source Breakdown Voltage	I_D=250µA, V_{GS}=0V	20			V
I_{DSS}	Zero Gate Voltage Drain Current	V_{DS}=16V, V_{GS}=0V			1	µA
		T_J=55°C			5	
I_{GSS}	Gate-Body leakage current	V_{DS}=0V, V_{GS}=±10V			100	nA
BV_{GSO}	Gate-Source Breakdown Voltage	V_{DS}=0V, I_G=±250uA	±12			V
$V_{GS(th)}$	Gate Threshold Voltage	V_{DS}=V_{GS} I_D=250uA	0.5	0.8	1	V
$I_{D(ON)}$	On state drain current	V_{GS}=4.5V, V_{DS}=5V	30			A
$R_{DS(ON)}$	Static Drain-Source On-Resistance	V_{GS}=10V, I_D=7A		16.4	21	mΩ
		T_J=125°C		23	28	
		V_{GS}=4.5V, I_D=6.6A		19	24	mΩ
		V_{GS}=2.5V, I_D=5.5A		25	32	mΩ
		V_{GS}=1.8V, I_D=2A		36	50	mΩ
g_{FS}	Forward Transconductance	V_{DS}=5V, I_D=7A		24		S
V_{SD}	Diode Forward Voltage	I_S=1A,V_{GS}=0V		0.7	1	V
I_S	Maximum Body-Diode Continuous Current				2.5	A
DYNAMIC PARAMETERS						
C_{iss}	Input Capacitance	V_{GS}=0V, V_{DS}=10V, f=1MHz		630		pF
C_{oss}	Output Capacitance			164		pF
C_{rss}	Reverse Transfer Capacitance			137		pF
R_g	Gate resistance	V_{GS}=0V, V_{DS}=0V, f=1MHz		1.5		Ω
SWITCHING PARAMETERS						
Q_g	Total Gate Charge	V_{GS}=4.5V, V_{DS}=10V, I_D=7A		9.3		nC
Q_{gs}	Gate Source Charge			0.6		nC
Q_{gd}	Gate Drain Charge			3.6		nC
$t_{D(on)}$	Turn-On DelayTime	V_{GS}=5V, V_{DS}=10V, R_L=1.4Ω, R_{GEN}=3Ω		5.7		ns
t_r	Turn-On Rise Time			11.5		ns
$t_{D(off)}$	Turn-Off DelayTime			31.5		ns
t_f	Turn-Off Fall Time			9.7		ns
t_{rr}	Body Diode Reverse Recovery Time	I_F=7A, dI/dt=100A/µs		15.2		ns
Q_{rr}	Body Diode Reverse Recovery Charge	I_F=7A, dI/dt=100A/µs		6.3		nC

A: The value of $R_{\theta JA}$ is measured with the device mounted on 1in^2 FR-4 board with 2oz. Copper, in a still air environment with T_A=25°C. The value in any given application depends on the user's specific board design. The currentand power rating is based on the t ≤ 10s thermal resistance rating.

B: Repetitive rating, pulse width limited by junction temperature.

C. The $R_{\theta JA}$ is the sum of the thermal impedence from junction to lead $R_{\theta JL}$ and lead to ambient.

D. The static characteristics in Figures 1 to 6,12,14 are obtained using 80µs pulses, duty cycle 0.5% max.

E. These tests are performed with the device mounted on 1 in^2 FR-4 board with 2oz. Copper, in a still air environment with T_A=25°C. The SOA curve provides a single pulse rating.

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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

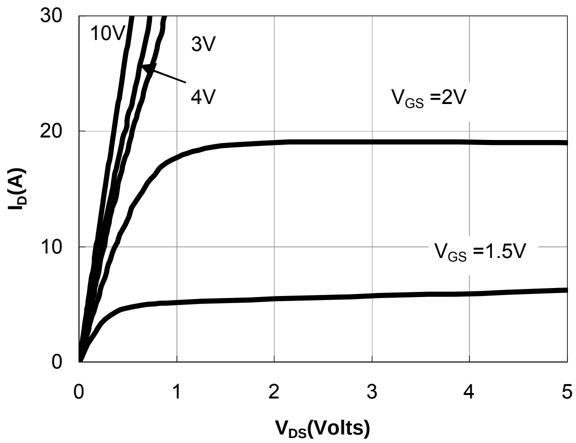

Figure 1: On-Regions Characteristics

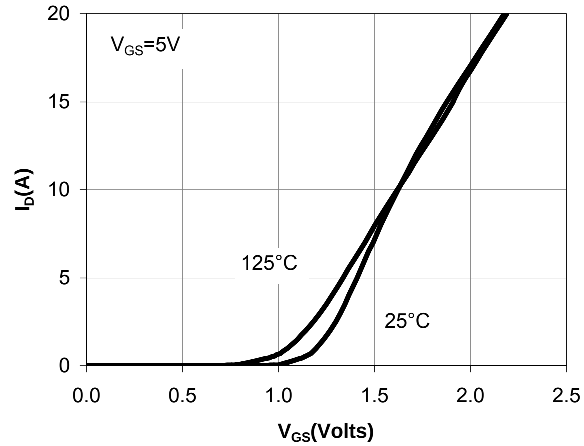

Figure 2: Transfer Characteristics

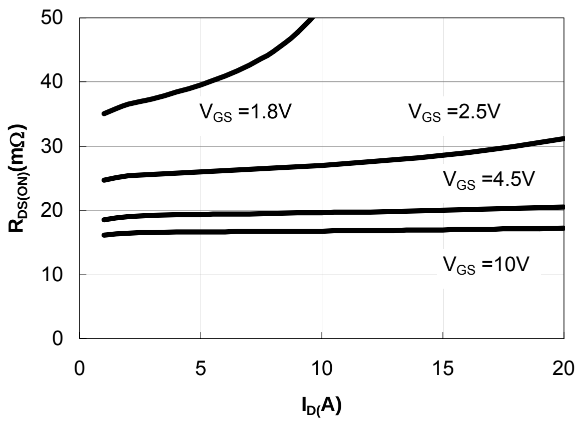

Figure 3: On-Resistance vs. Drain Current and Gate Voltage

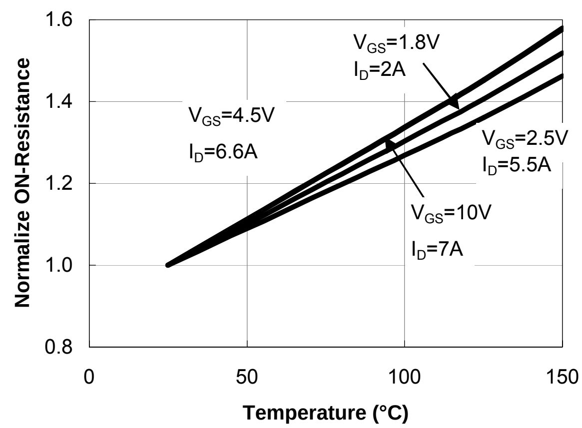

Figure 4: On-Resistance vs. Junction Temperature

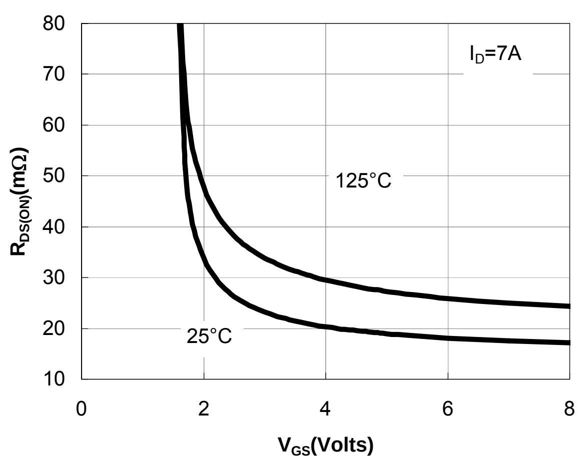

Figure 5: On-Resistance vs. Gate-Source Voltage

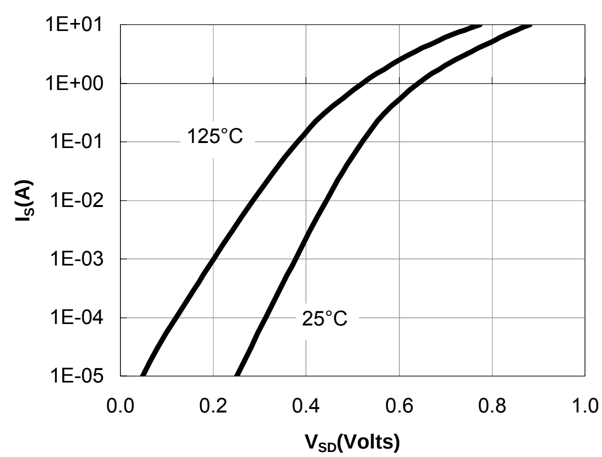

Figure 6: Body-Diode Characteristics

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

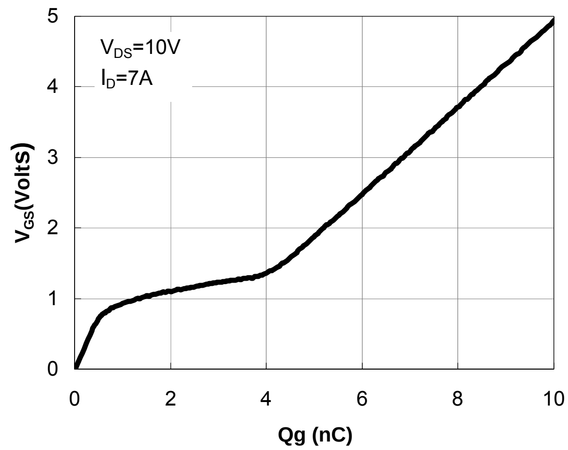

Figure 7: Gate-Charge Characteristics

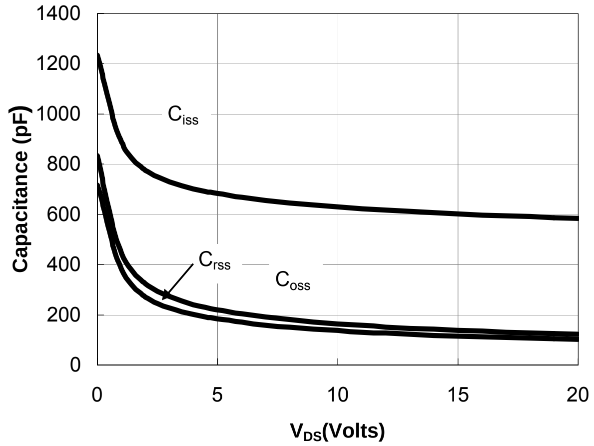

Figure 8: Capacitance Characteristics

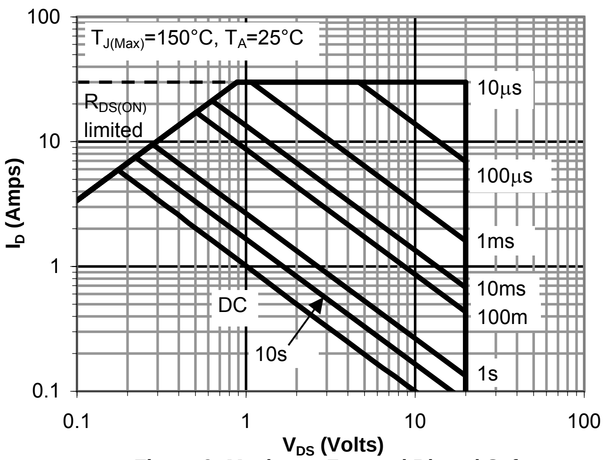

Figure 9: Maximum Forward Biased Safe Operating Area (Note E)

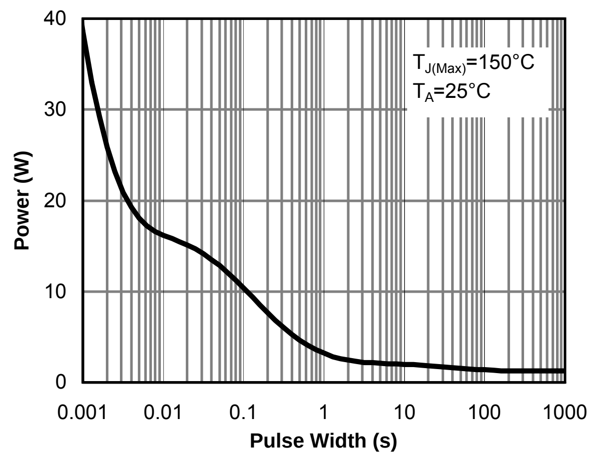

Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note E)

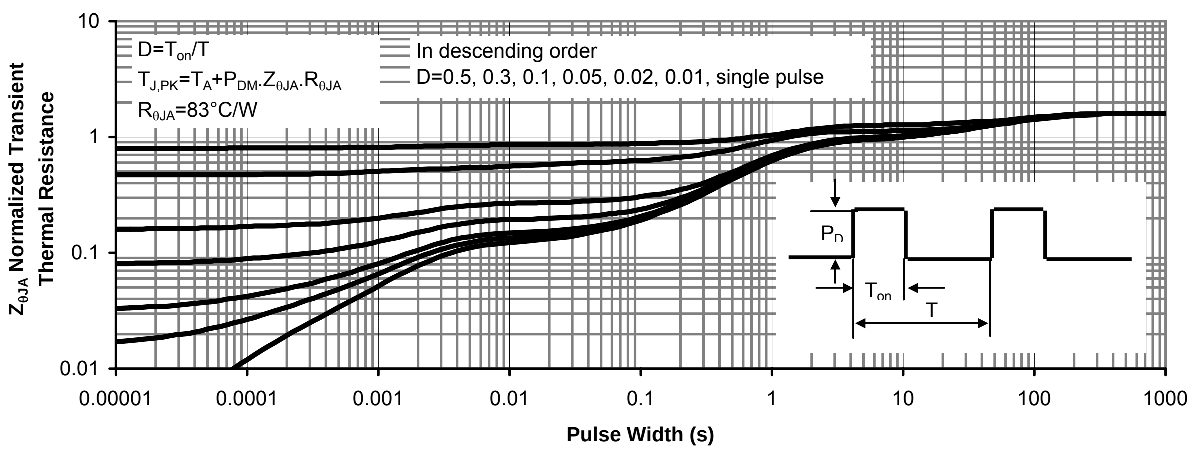

Figure 11: Normalized Maximum Transient Thermal Impedance